

LIST OF PRIOR ART CITED BY APPLICANT

(PTO-1449)

OCT 27 2004

ATTY. DOCKET NO.
P-0483APPLN. SERIAL NO.
10/624,524APPLICANT(S)
Yong-Hee LEE and Joon JANGFILING DATE
July 23, 2003GROUP
2612

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS

U.S. PATENT APPLICATIONS

*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
NT	10-2004-0006710	1/24/04	KOREA	—	—	Part. Abst	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

NT	Korean Office Action dated July 28, 2004

EXAMINER

/Nhan Tran/

DATE CONSIDERED

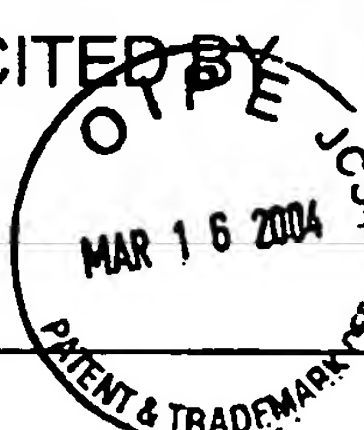
11/03/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

DYK/RAV:knv

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UNKNOWN

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
NT	5,537,175	7/16/96	Kamaya et al.	—	—	

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
NT	2001/0038412 A1	11/8/2001	McNelly et al.	//	//	
NT	2002/0051060 A1	5/2/2002	Wada	//	//	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

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